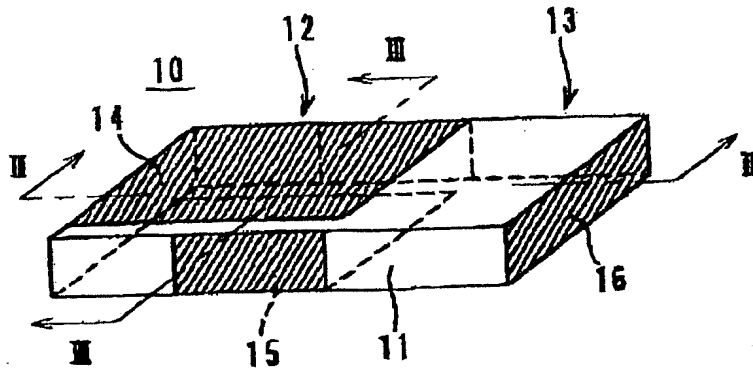
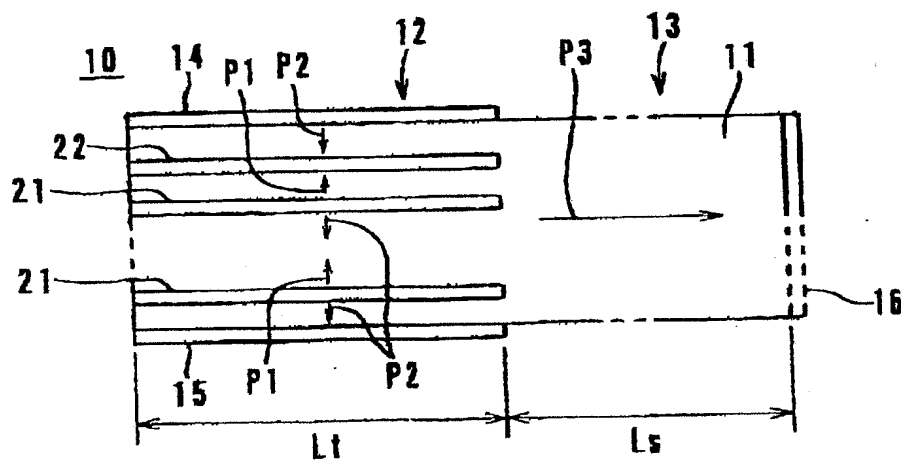


【書類名】 図面

【図1】 FIG.1



【図2】 FIG.2



【図3】 FIG.3

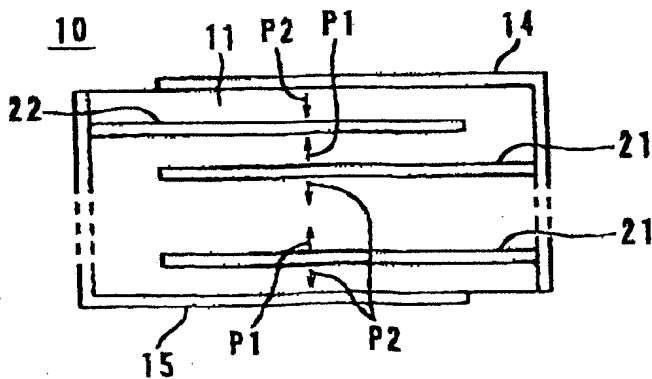


Figure 1 is a block diagram of a measuring device. The device includes a microcomputer (31) connected to a measuring device (10). The measuring device (10) consists of a power supply (32), a switch (34), a measuring unit (33), and a display (35). The measuring unit (33) is connected to a sensor (12) which is part of a probe (13) with a tip (14). The probe is used to measure a sample (15) on a substrate (16). The measuring unit (33) is also connected to a ground (38a) and a signal line (38b) which is connected to the display (35).

Fig. 1 is a schematic diagram of a measuring device 33. It consists of a vertical plate 37 with two horizontal arms 38a and 38b. A horizontal rod 10 is positioned to the right of the plate. A shaded rectangular block 14 is mounted on the rod 10, with a hatched section 15. A label 'MEASURING DEVICE 33' is on the left, and a label '11' is at the bottom right.

【図6】

FIG. 6A

(A)

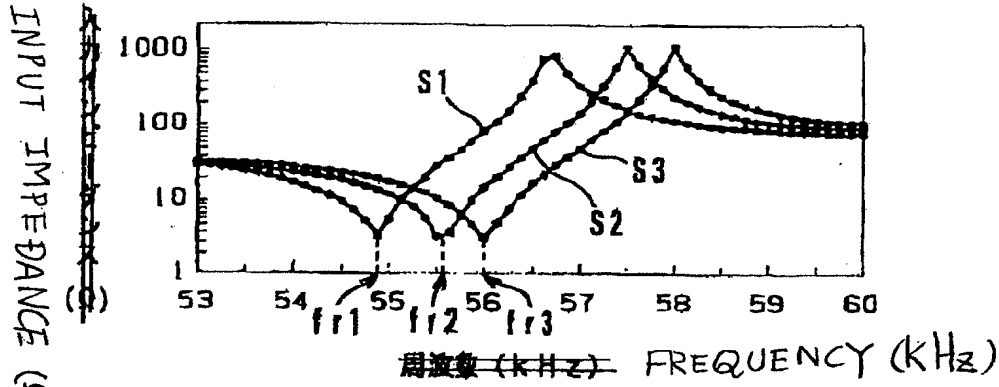


FIG. 6B

(B)

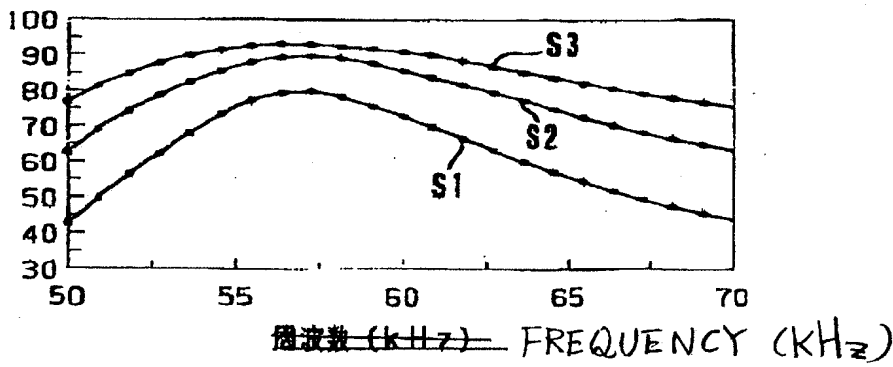
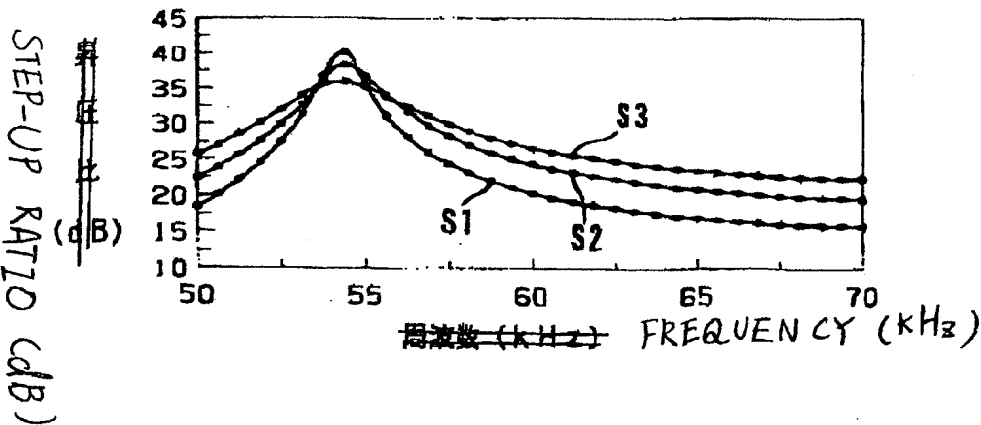
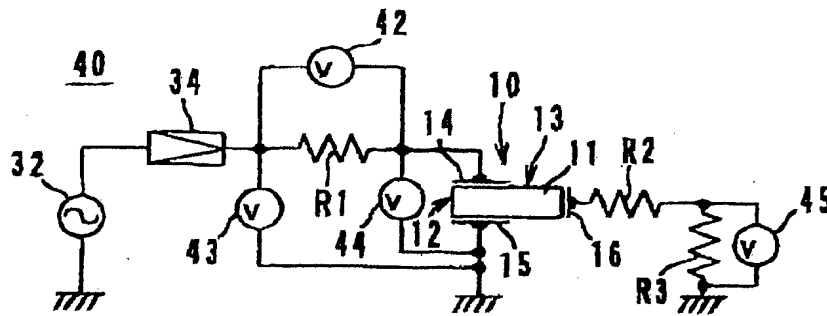


FIG. 6C

(C)



~~FIG. 7~~ FIG. 7



~~FIG. 8~~ FIG. 8

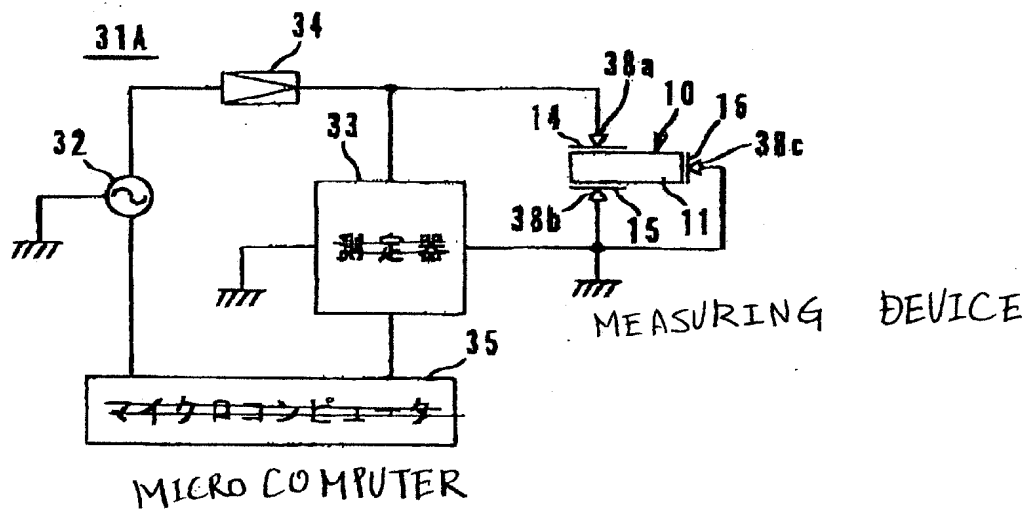
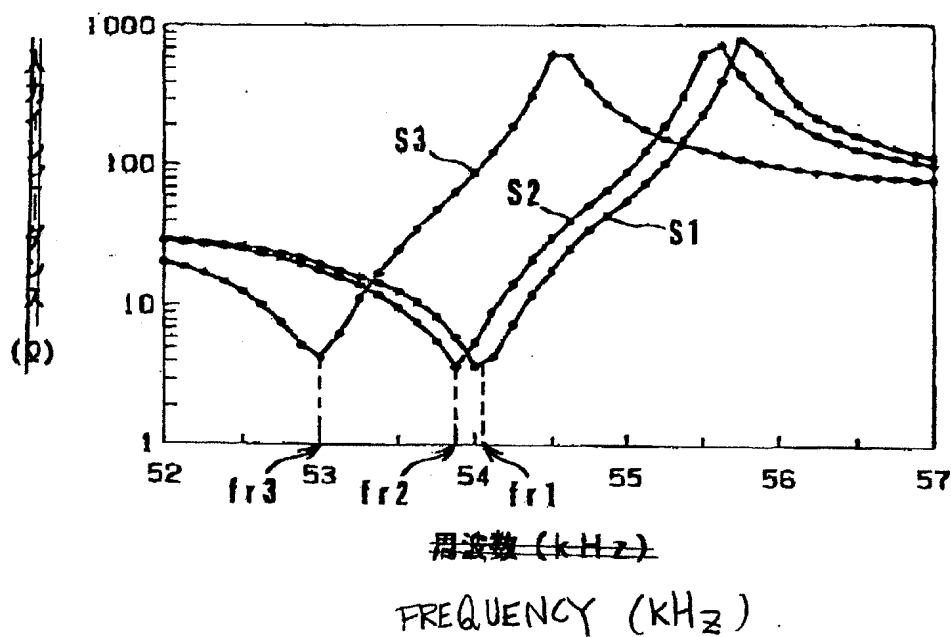


FIG. 9



【図10】

FIG.10A

~~(A)~~

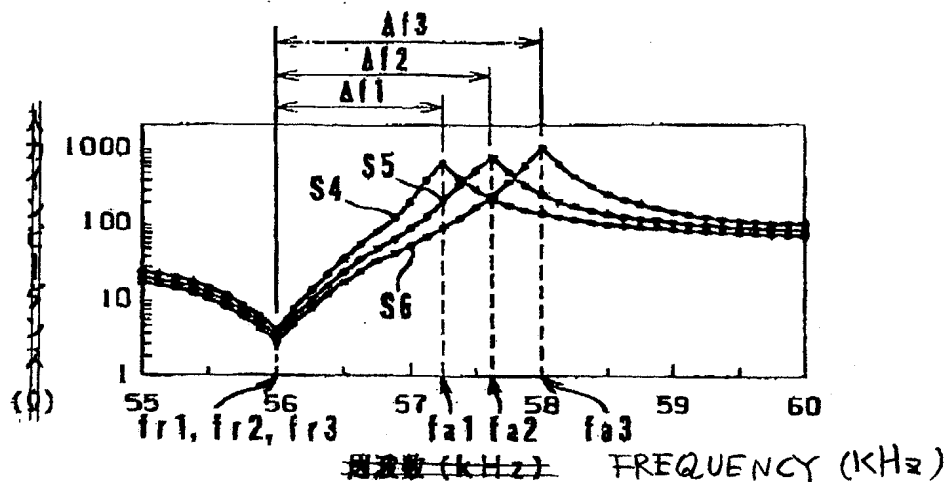


FIG.10B

~~(B)~~

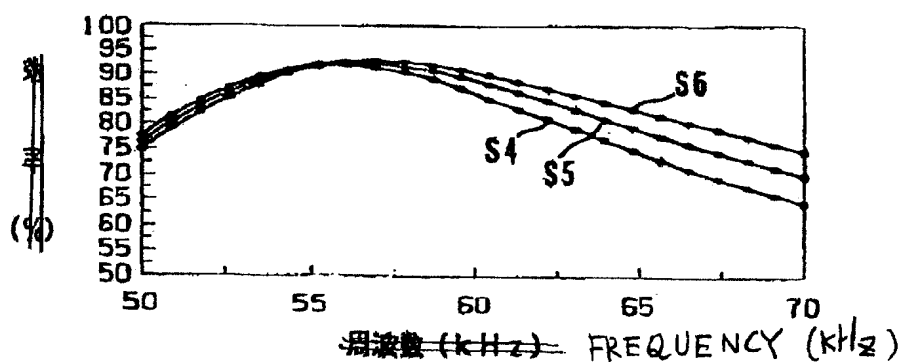
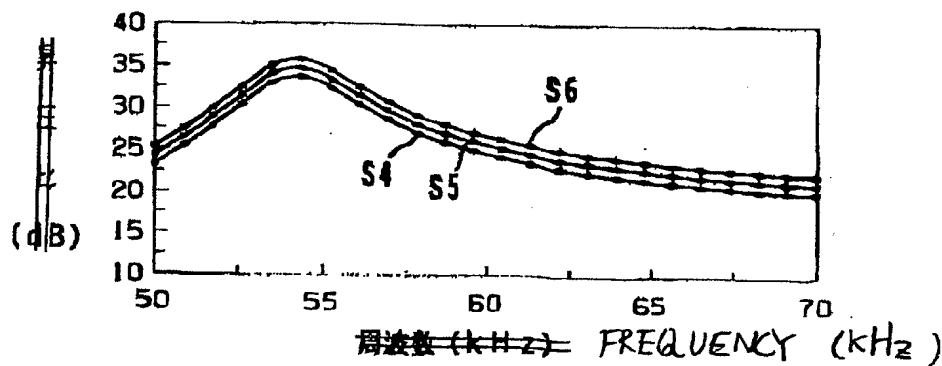


FIG.10C

~~(C)~~



~~FIG. 11A~~

INPUT IMPEDANCE (Ω)

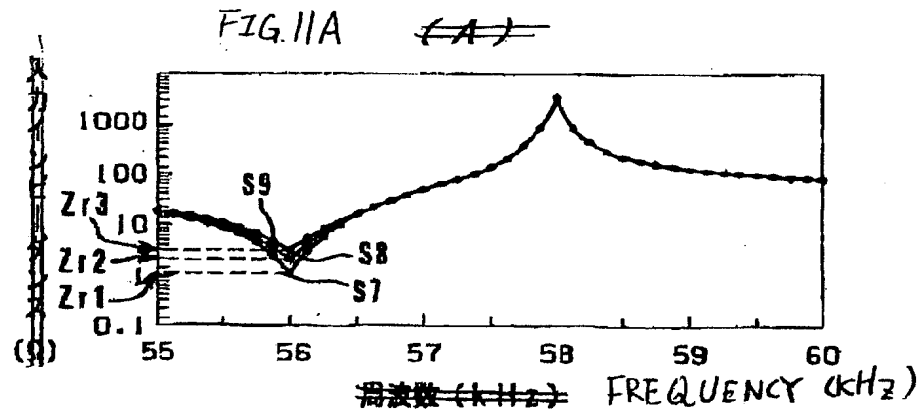


FIG. 11B

~~(B)~~

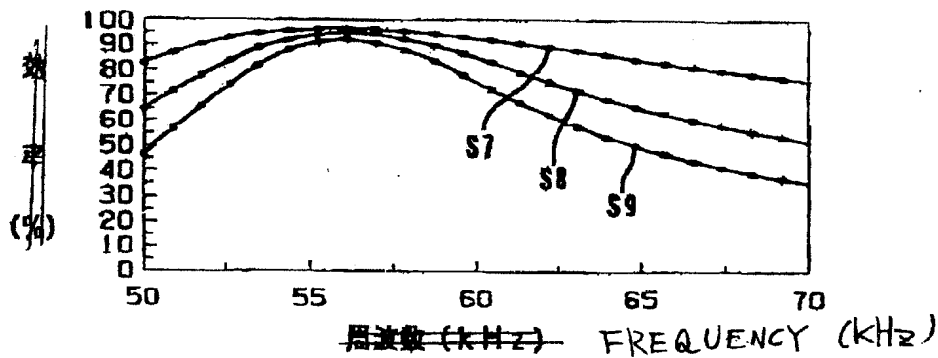


FIG. 11C

~~(C)~~

STEP-UP RATIO (dB)

